TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSII<sup>.5</sup>)

# 2SK1365

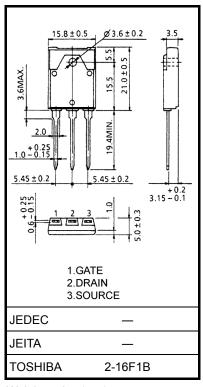
#### Switching Power Supply Applications

Unit: mm

 $\begin{array}{ll} \bullet & \text{Low drain-source ON resistance} & : R_{DS} \, (\text{ON}) = 1.5 \, \Omega \, (\text{typ.}) \\ \bullet & \text{High forward transfer admittance} & : |Y_{fs}| = 4.0 \, S \, (\text{typ.}) \\ \bullet & \text{Low leakage current} & : I_{DSS} = 300 \, \mu\text{A} \, (\text{max}) \, (V_{DS} = 800 \, \text{V}) \\ \bullet & \text{Enhancement mode} & : V_{th} = 1.5 {\sim} 3.5 \, V \, (V_{DS} = 10 \, \text{V}, \, I_{D} = 1 \, \text{mA}) \\ \end{array}$ 

### Absolute Maximum Ratings (Ta = 25°C)

Characteris	tics	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	1000	V	
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		$V_{DGR}$	1000	٧	
Gate-source voltage		$V_{GSS}$	±20	٧	
Drain current	DC (Note 1)	I <sub>D</sub>	7	Α	
	Pulse (Note 1)	I <sub>DP</sub>	21	A	
Drain power dissipation	(Tc = 25°C)	$P_{D}$	90	W	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	



Weight: 5.8 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	1.39	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	41.6	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

This transistor is an electrostatic-sensitive device.

Please handle with caution.

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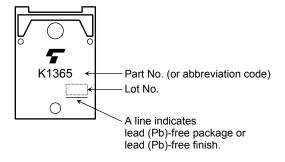
# **Electrical Characteristics (Ta = 25°C)**

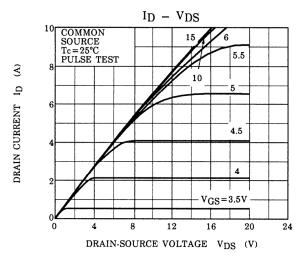
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	_	_	±50	nA
Drain cut-off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V	_	_	300	μA
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	1000	_	_	V
Gate threshold v	/oltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R <sub>DS</sub> (ON)	I <sub>D</sub> = 4 A, V <sub>GS</sub> = 10 V	_	1.5	1.8	Ω
Forward transfer	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 4 A		4.0	_	S
Input capacitano	ce	C <sub>iss</sub>		_	1300	_	
Reverse transfer capacitance $C_{rss}$ $V_{DS} = 25 \text{ V}, V_{GS} = 25 \text{ V}$		V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	100	_	pF	
Output capacitance		Coss		_	180	_	
Switching time	Rise time	t <sub>r</sub>	V <sub>GS</sub> <sub>0V</sub>	_	25	_	
	Turn-on time	t <sub>on</sub>		_	40	_	20
	Fall time	t <sub>f</sub>		_	20	_	ns
	Turn-off time	t <sub>off</sub>	$V_{DD} = 400V$ Duty $\leq 1\%$ , $t_{W} = 10 \mu s$	_	100	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	120	_	nC
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 7 \text{ A}$	_	70	_	
Gate-drain ("miller") charge		Q <sub>gd</sub>	]		50	_	

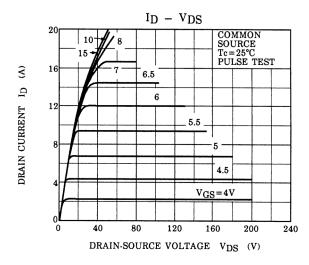
# Source-Drain Ratings and Characteristics (Ta = 25°C)

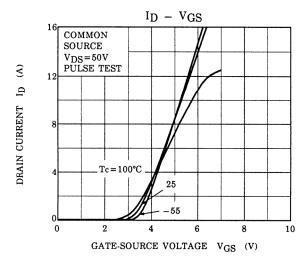
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	7	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>		_	_	21	Α
Forward voltage (diode)	$V_{DSF}$	I <sub>DR</sub> = 7 A, V <sub>GS</sub> = 0 V	_	_	-1.9	V

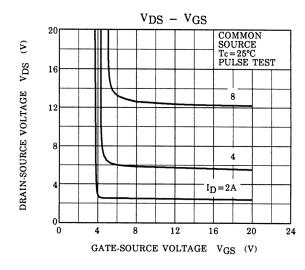
# Marking

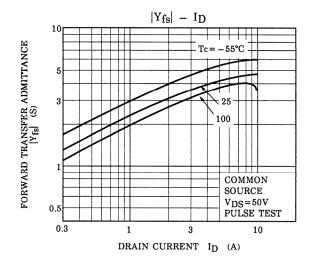


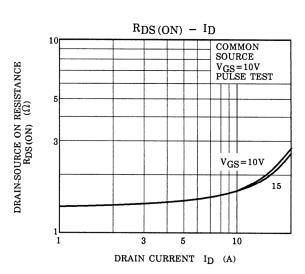


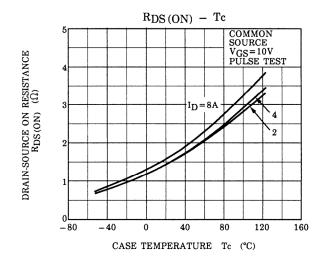


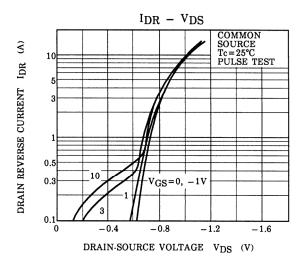


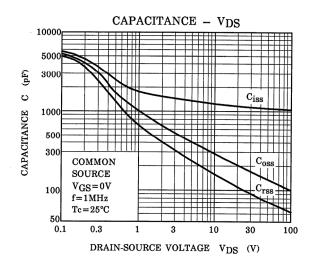


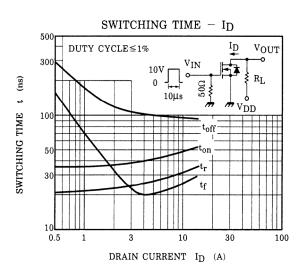


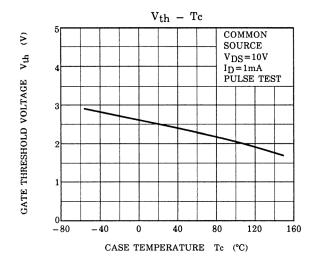


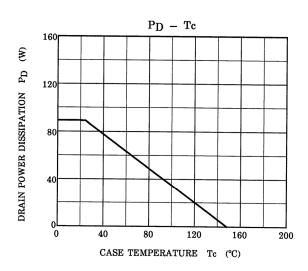


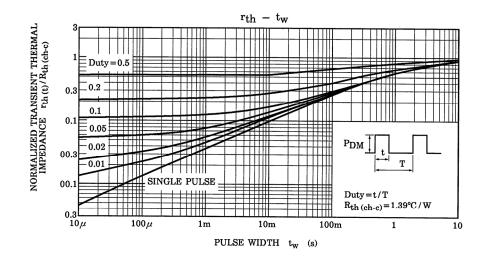




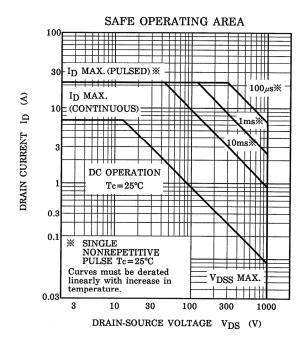








5



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